

APPENDIX E: TEST SEQUENCES

1. Test sequence is generated based on below parameters of the DUT:
 - a. Measured maximum power (P_{max})
 - b. Measured Tx_power_at_SAR_design_target (P_{limit})
 - c. Reserve_power_margin (dB)
 - $P_{reserve}$ (dBm) = measured P_{limit} (dBm) – Reserve_power_margin (dB)
 - d. SAR_time_window (100s for FCC)
2. Test Sequence 1 Waveform:

Based on the parameters above, the Test Sequence 1 is generated with one transition between high and low Tx powers. Here, high power = P_{max} ; low power = $P_{max}/2$, and the transition occurs after 80 seconds at high power P_{max} . As long as the power enforcement is taking into effect during one 100s/60s time window, the validation test with this defined test sequence 1 is valid, otherwise, select other radio configuration (band/DSI within the same technology group) having lower P_{limit} for this test. The Test sequence 1 waveform is shown below:

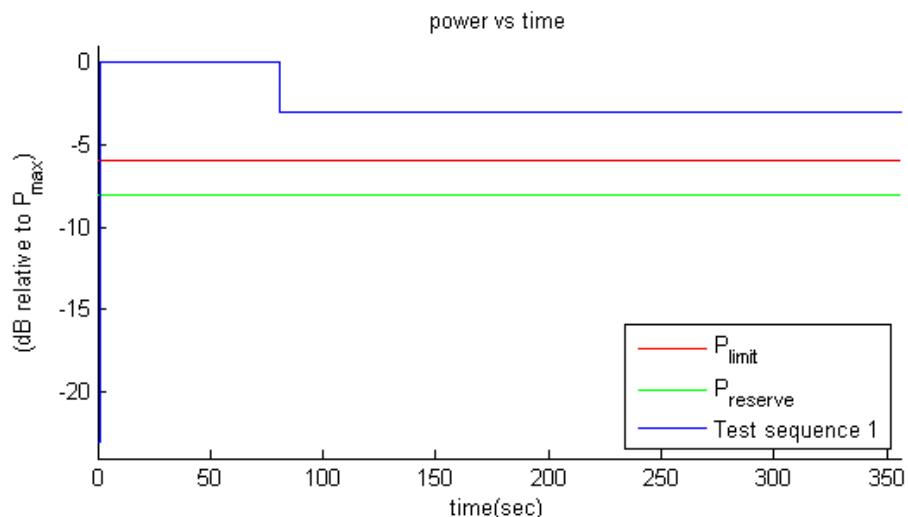


Figure E-1
Test sequence 1 waveform

FCC ID: C3K1995	 PCTEST <small>Proud to be part of element</small>	PART 2 RF EXPOSURE EVALUATION REPORT	Microsoft	Approved by: Quality Manager
Test Dates: 07/26/2021-09/01/2021	DUT Type: Portable Handset			APPENDIX E: Page 1 of 3

3. Test Sequence 2 Waveform:

Based on the parameters described above, the Test Sequence 2 is generated as described in Table 10-1, which contains two 170 second-long sequences (yellow and green highlighted rows) that are mirrored around the center row of 20s, resulting in a total duration of 360 seconds:

Table E-1
Test Sequence 2

Time duration (seconds)	dB relative to P_{limit} or $P_{reserve}$
15	$P_{reserve} - 2$
20	P_{limit}
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 6$
20	P_{max}
15	P_{limit}
15	$P_{reserve} - 5$
20	P_{max}
10	$P_{reserve} - 3$
15	P_{limit}
10	$P_{reserve} - 4$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 4$
15	P_{limit}
10	$P_{reserve} - 3$
20	P_{max}
15	$P_{reserve} - 5$
15	P_{limit}
20	P_{max}
10	$P_{reserve} - 6$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
20	P_{limit}
15	$P_{reserve} - 2$

FCC ID: C3K1995	 PCTEST Proud to be part of 	PART 2 RF EXPOSURE EVALUATION REPORT		Approved by: Quality Manager
Test Dates: 07/26/2021-09/01/2021	DUT Type: Portable Handset			APPENDIX E: Page 2 of 3

The Test Sequence 2 waveform is shown in Figure E-2.

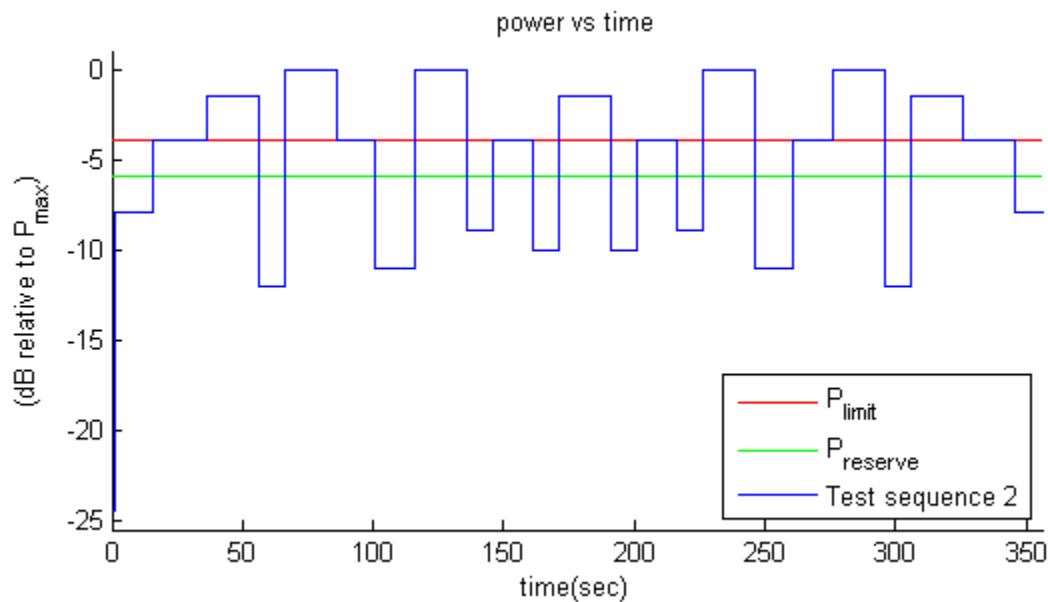


Figure E-2
Test sequence 2 waveform

FCC ID: C3K1995	PCTEST Proud to be part of element	PART 2 RF EXPOSURE EVALUATION REPORT	Microsoft	Approved by: Quality Manager
Test Dates: 07/26/2021-09/01/2021	DUT Type: Portable Handset			APPENDIX E: Page 3 of 3